

<b>Notice of References Cited</b>	Application/Control No. 10/692,653	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
	Examiner John S. Chu	Art Unit 1752	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,638,850	06-1997	Hazinski et al.	135/120.1
*	B	US-4,590,263	05-1986	Desjarlais et al.	534/558
*	C	US-4,400,458	08-1983	Walkow et al.	430/157
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 59104995 A	06-1984	Japan	HAKIRI, MINORU	B41M 05/18
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.